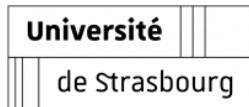
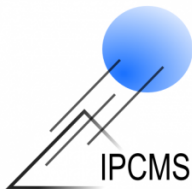


Towards the superconductivity in $\text{La}_3\text{Ni}_2\text{O}_7$ thin films under large compressive strain.

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Introduction

- 1 Superconductivity is still a very active field of research.
- 2 The theory and concept behind high temperature (or unconventional) superconductor is still not well known.
- 3 new high temperature superconductors could be a huge revolution in many domains in science and engineering.

Current research on the field

- 1 Nickelates are close to Cuprates, well known for their superconductivity at high temperature.
- 2 Discovery of high temperature (80°K) superconductivity in a bulk crystal of $\text{La}_3\text{Ni}_2\text{O}_3$ under high pressure (20 GPa) - 2023 [1].

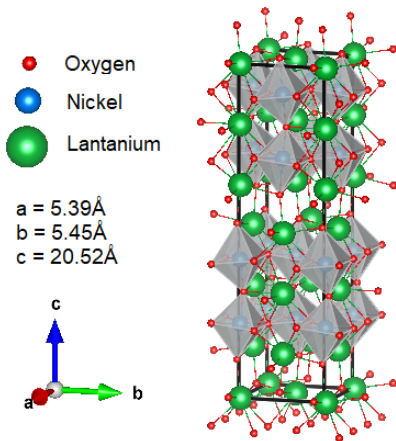


Figure 1 – Unit cell of the $\text{La}_3\text{Ni}_2\text{O}_3$ crystal. [2]

Octahedra tilting

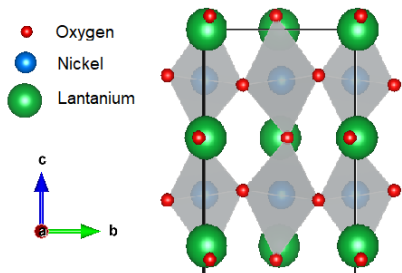


Figure 2 – Octahedra disposition in the bulk crystal of $\text{La}_3\text{Ni}_2\text{O}_7$

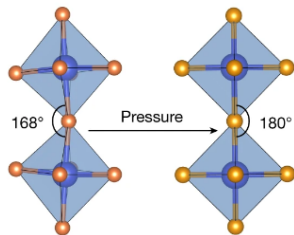


Figure 3 – The angle between two adjacent octahedra changes from 168° in the ambient-pressure to 180° in the high-pressure. from [1].

The lattices parameters

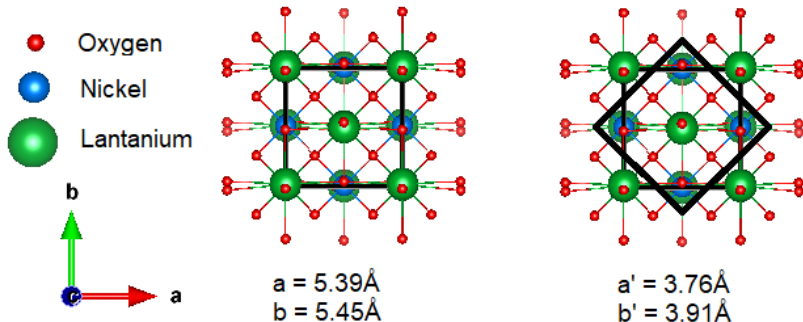


Figure 4 – Usual and diagonal in-plane lattice parameters.

The two substrates

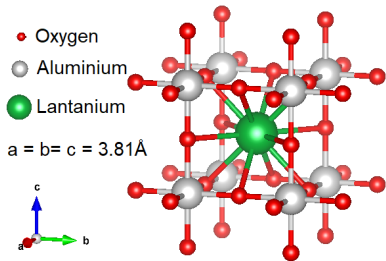


Figure 5 – Unit cell of the La Al O_3 (LAO) substrate. [3]

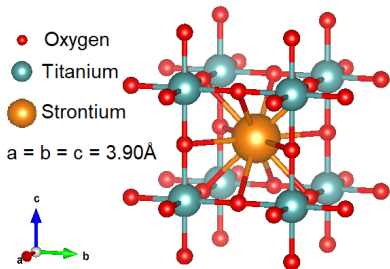
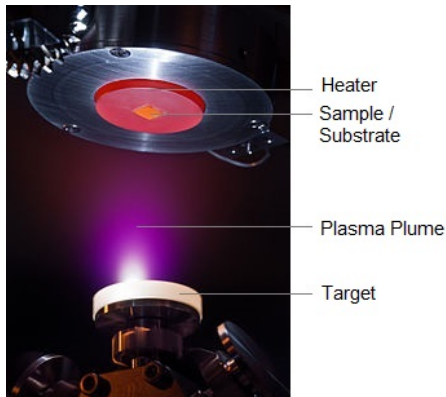


Figure 6 – Unit cell of the Sr Ti O_3 (STO) substrate. [4]

These will apply a strain on the crystal we want to grow.

$$\epsilon_{LAO} = -1.12\% ; \epsilon_{STO} = 1.88\% [5]$$

The PLD (Pulsed Laser Deposition)



- 1 Under vacuum beside a set concentration of dioxygen, a pulsed laser in the X-ray is being shun on a target made of $\text{La}_3\text{Ni}_2\text{O}_7$.
- 2 The target turn into a plasma plume and will fix on the heated substrate layer by layer.
- 3 An electron beam reflection gives us information on the number of layer created.

Figure 7 – Photo of the grow process of a crystal by PLD.

Schematic of a sample

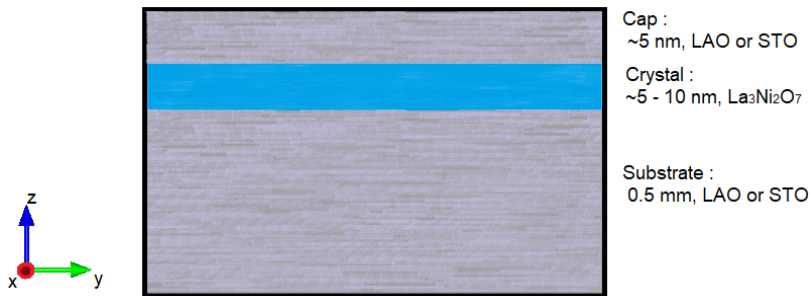


Figure 8 – drawing of the different layers of a given sample.

The AFM (Atomic force microscope)

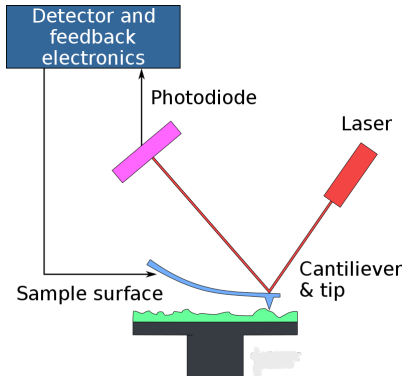


Figure 9 – Schematic of the atomic force microscope, vertical resolution in the Å.

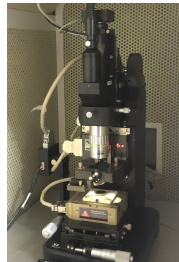


Figure 10 – Photo of the atomic force microscope.

The AFM (Atomic force microscope)

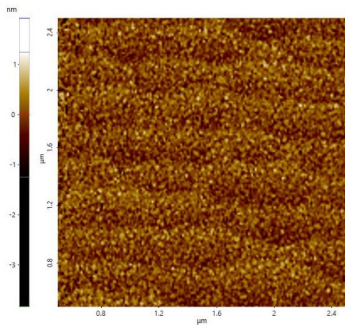


Figure 11 – Sample C (LAO substrate) topography realized with AFM, roughness = 0.28 nm.

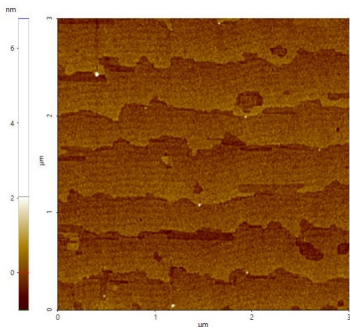


Figure 12 – Sample D (STO substrate) topography realized with AFM, roughness = 0.22 nm.

Principle of the XRD (X-Ray Diffraction)

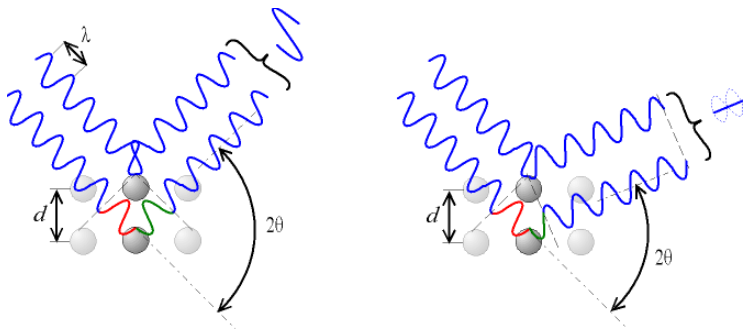


Figure 13 – Schematic of X-ray diffracting on a crystal plane following Bragg's law.

$$2d \sin \theta = n\lambda; \lambda = 1.5410^{-10} \text{ m}$$

Our results on XRD measurement - LAO substrate

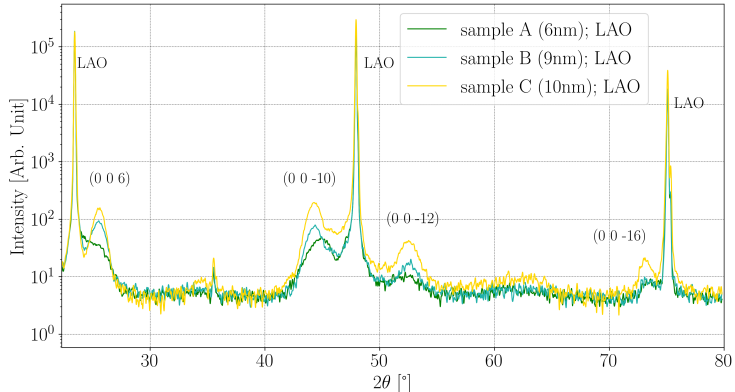


Figure 14 – Intensity versus angle for samples with different width grown on LAO substrate.

Our results on XRD measurement - STO substrate

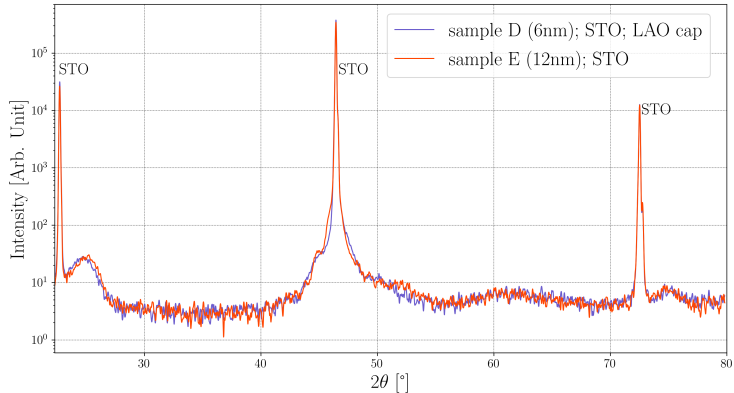


Figure 15 – Intensity versus angle for samples with different width grown on STO substrate.

Principle of the resistivity measurement

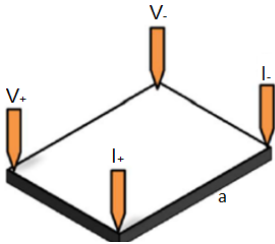


Figure 16 – Schematic of a four points resistivity measurement.

Van der Pauw measurement conditions :

- 1 contacts are on the circumference.
- 2 contacts are sufficiently small.
- 3 sample is homogeneous.
- 4 sample is singly connected (contains no holes).

Our results on conductivity measurement - LAO substrate

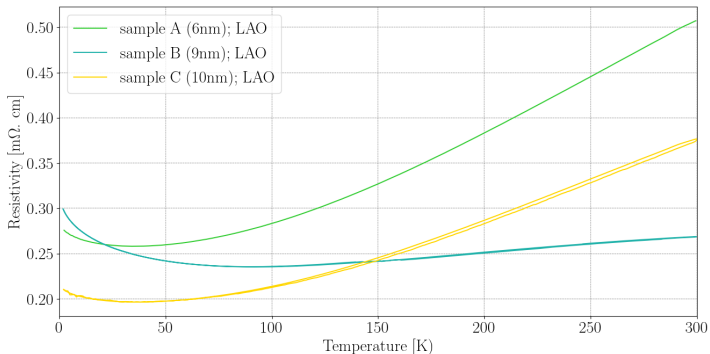


Figure 17 – resistivity versus temperature for samples with different width grown on LAO substrate.

Our results on resistivity measurement - STO substrate

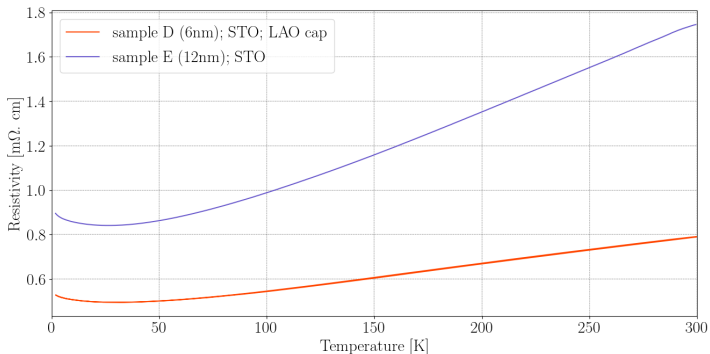


Figure 18 – resistivity versus temperature for samples with different width grown on STO substrate.

Resistivity as a power of temperature

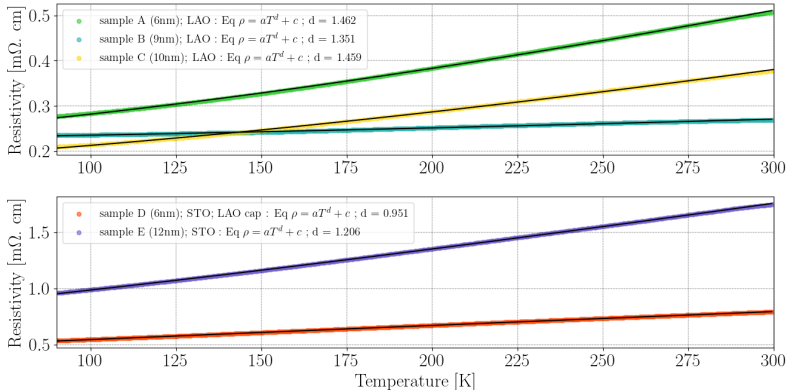


Figure 19 – Fitting of the resistivity as a power of temperature for all of our samples.

The inconclusive topotactic reduction

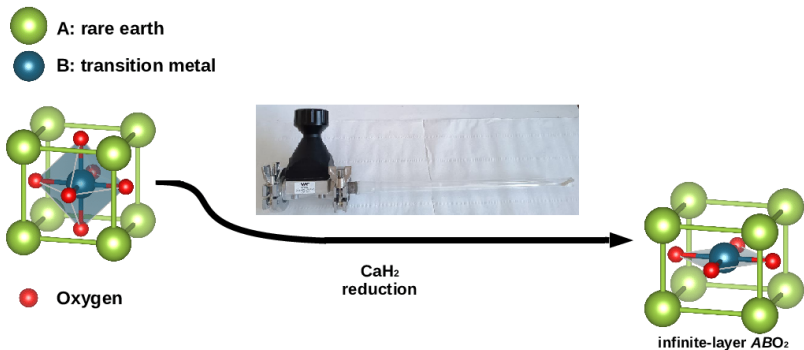


Figure 20 – Schematic of the process of the chemical topotactic reduction

Conclusion

- ① traces of strange metal behavior were found in one of our samples.
- ② Topotactic reduction was unable to create infinite-layer but instead seems to destroy the unit cell, perhaps through a chemical reaction.
- ③ To go further : we still can try to measure the conductivity of the samples under pressure like [1].



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More about the PLD.

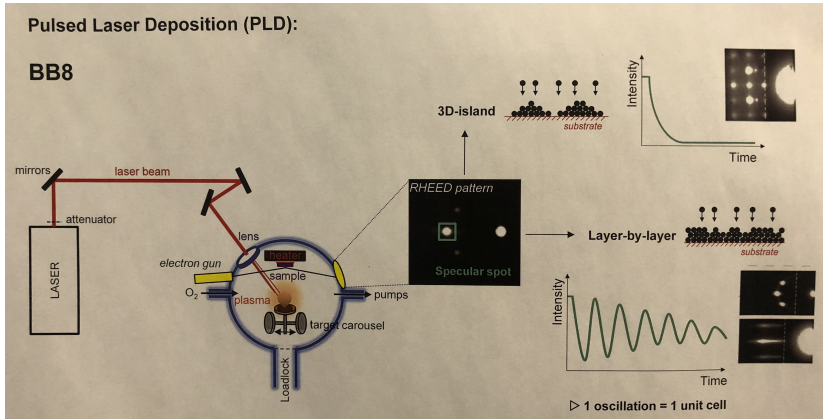


Figure 21 – Detailed sketch of the PLD and the electron beam reflection.